

<b>Notice of References Cited</b>	Application/Control No. 10/774,513	Applicant(s)/Patent Under Reexamination LOO, FOK KEI	
	Examiner Scott Sun	Art Unit 2182	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0076438 A1	04-2003	Ishimaru, Yoshiaki	348/372
*	B	US-2004/0187157 A1	09-2004	Chong et al.	725/086
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N					
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